

August 1990 Revised August 1999

74FR245

Octal Bidirectional Transceiver with 3-STATE Outputs

General Description

The 74FR245 contains eight non-inverting bidirectional buffers with 3-STATE outputs and is intended for bus-oriented applications. Current sinking capability is 64 mA on both the A and B Ports. The Transmit/Receive (T/\overline{R}) input determines the direction of data flow through the bidirectional transceiver. Transmit (active-HIGH) enables data from A Ports to B Ports; Receive (active-LOW) enables data from B Ports to A Ports. The Output Enable input, when HIGH, disables both A and B Ports by placing them in a High Z condition.

Features

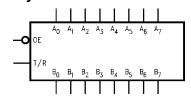
- Non-inverting buffers
- Bidirectional data path
- A and B output sink capability of 64 mA, source capability of 15 mA
- Guaranteed pin-to-pin skew

Ordering Code:

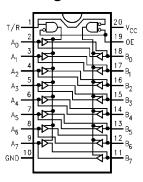
Order Number	Package Number	Package Description
74FR245SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74FR245SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74FR245PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description				
ŌE	Output Enable Input (Active-LOW)				
T/R	Transmit/Receive Input				
A ₀ -A ₇	Side A Inputs or 3-STATE Outputs				
B ₀ –B ₇	Side B Inputs or 3-STATE Outputs				

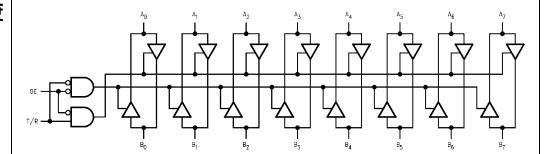
Truth Table

Inp	uts	Output				
OE	T/R	Output				
L	L	Bus B Data to Bus A				
L	Н	Bus A Data to Bus B				
Н	Χ	High Z State				

H = HIGH Voltage Level L = LOW Voltage Level

X = Immaterial

Logic Diagram



Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

 $\begin{array}{ll} \mbox{Storage Temperature} & -65^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to } +125^{\circ}\mbox{C} \\ \end{array}$

Junction Temperature under Bias -55° C to $+150^{\circ}$ C V_{CC} Pin Potential to Ground Pin -0.5V to +7.0V

Voltage Applied to Output in HIGH State (with V_{CC} = 0V)

 $\begin{array}{lll} \mbox{Standard Output} & -0.5\mbox{V to V}_{\mbox{CC}} \\ \mbox{3-STATE Output} & -0.5\mbox{V to +5.5V} \end{array}$

Current Applied to Output

in LOW State (Max) ${\rm twice\ the\ rated\ I_{OL}\ (mA)}$ ESD Last Passing Voltage (Min) ${\rm 4000V}$

Free Air Ambient Temperature 0° C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter	Min	Тур	Max	Units	V _{CC}	Conditions
V _{IH}	Input HIGH Voltage	2.0			V		Recognized HIGH Signal
V _{IL}	Input LOW Voltage			0.8	V		Recognized LOW Signal
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH Voltage	2.4			V	Min	$I_{OH} = -3 \text{ mA } (A_n, B_n)$
		2.0			V	Min	$I_{OH} = -15 \text{ mA } (A_n, B_n)$
V _{OL}	Output LOW Voltage			0.55	V	Min	$I_{OL} = 64 \text{ mA } (A_n, B_n)$
I _{IH}	Input HIGH Current			5	μΑ	Max	$V_{IN} = 2.7V (\overline{OE}, T/\overline{R})$
I _{BVI}	Input HIGH Current Breakdown Test			7	μА	Max	$V_{IN} = 7.0V (\overline{OE}, T/\overline{R})$
I _{BVIT}	Input HIGH Current Breakdown Test (I/O)			100	μА	Max	$V_{IN} = 5.5V (A_n, B_n)$
I _{IL}	Input LOW Current			-250	μΑ	Max	$V_{IN} = 0.5V (\overline{OE}, T/\overline{R})$
V_{ID}	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu\text{A}$
							All Other Pins Grounded
I _{OD}	Output Circuit			3.75		0.0	V _{IOD} = 150 mV
	Leakage Current			3.73	μА	0.0	All Other Pins Grounded
I _{IH} + I _{OZH}	Output Leakage Current			25	μΑ	Max	$V_{OUT} = 2.7V (A_n, B_n)$
$I_{IL} + I_{OZL}$	Output Leakage Current			-150	μΑ	Max	$V_{OUT} = 0.5V (A_n, B_n)$
los	Output Short-Circuit Current	-100		-225	mA	Max	$V_{OUT} = 0.0V (A_n, B_n)$
I _{CEX}	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC} (A_n, B_n)$
I _{ZZ}	Bus Drainage Test			100	μΑ	0.0	$V_{OUT} = 5.25V (A_n, B_n)$
I _{CCH}	Power Supply Current		55	75	mA	Max	All Outputs HIGH
I _{CCL}	Power Supply Current		75	110	mA	Max	All Outputs LOW
I _{CCZ}	Power Supply Current		55	75	mA	Max	Outputs 3-STATE
C _{IN}	Input Capacitance		8.0		pF	5.0	ŌE, T/R
			17.0		pF	5.0	A _n , B _n

AC Electrical Characteristics

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	1.0	2.6	3.9	1.0	3.9	ns
t _{PHL}	A_n to B_n or B_n to A_n	1.0	1.7	3.9	1.0	3.9	115
t _{PZH}	Output Enable Time	2.5	5.0	7.0	2.5	7.0	ns
t _{PZL}		2.5	4.3	7.0	2.5	7.0	115
t _{PHZ}	Output Disable Time	1.7	3.7	6.5	1.7	6.5	200
t _{PLZ}		1.7	3.6	6.5	1.7	6.5	ns

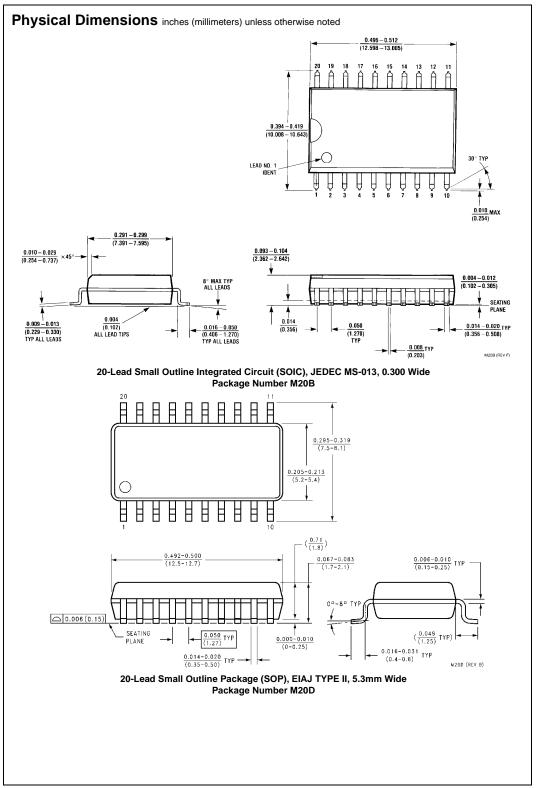
Extended AC Characteristics

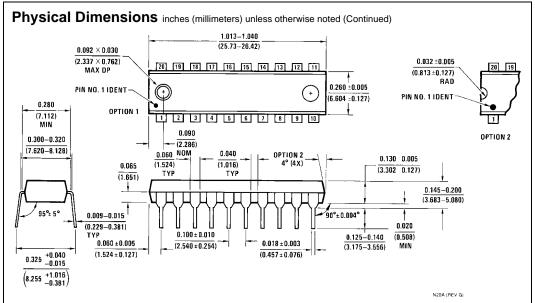
Symbol	Parameter	$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$		$T_A = 0$ °C to +70°C		Units
		V _{CC} =	= + 5.0V	$\mathbf{V_{CC}} = +5.0\mathbf{V}$		
		C _L =	C _L = 250 pF (Note 4)			
		Eight Outputs Switching				
		(No	te 3)			
		Min	Max	Min	Max	
t _{PLH}	Propagation Delay	1.0	5.9	2.5	7.5	ns
t _{PHL}	A_n to B_n or B_n to A_n	1.0	5.9	2.5	7.5	113
t _{PZH}	Output Enable Time	2.5	11.9			ns
t _{PZL}		2.5	11.9			113
t _{PHZ}	Output Disable Time	1.3	6.5			ns
t _{PLZ}		1.3	6.5			113
t _{OSHL}	Pin to Pin Skew		1.7			ns
(Note 5)	for HL Transitions	1.7				113
t _{OSLH}	Pin to Pin Skew	1.0				ns
(Note 5)	for LH Transitions					115
t _{OST}	Pin to Pin Skew	3.3				ns
(Note 5)	for HL/LH Transitions					

Note 3: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase, i.e., all LOW-to-HIGH, HIGH-to-LOW, 3-STATE-to-HIGH, etc.

Note 4: These specifications guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

Note 5: Skew is defined as the absolute value of the difference between the actual propagation delays for any two outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW (t_{OSHL}), LOW-to-HIGH (t_{OSLH}), or HIGH-to-LOW and/or LOW-to-HIGH (t_{OST}). Specifications guaranteed with all outputs switching in phase.





20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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